

Form 1449*	Atty. Docket No.: 1327.008US1	Serial No. Unknown
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	Applicant: Mark Lynn Jenson et al.	
	Filing Date: Herewith	Group: Unknown

U.S. PATENT DOCUMENTS

**Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<u>JL</u>	4,207,119	06/10/1980	Tyan	136	89 TF	06/02/78

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**Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation Yes No
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<u>n</u>	Aramoto, T., et al., "16.0% Efficient Thin-Film CdS/CdTe Solar Cells", Jpn. J. Appl. Phys., Vol. 36, Pt. 1, No. 10, pp. 6304-6305, (1997) October 1997
<u>n</u>	Birkmire, R.W., et al., "Polycrystalline Thin Film Solar Cells: Present Status and Future Potential", Annu. Rev. Mater. Sci., 27, pp. 625-653, (1997) (no month)
<u>n</u>	Chu, T.L., et al., "13.4% efficient thin-film CdS/CdTe solar cells", J. Appl. Phys., 70(12), pp. 7608-7612, (Dec. 15, 1991)
<u>n</u>	Dudney, N.J., et al., "Nanocrystalline $\text{Li}_x\text{Mn}_{2-y}\text{O}_4$ Cathodes for Solid-State Thin-Film Rechargeable Lithium Batteries", Journal of the Electrochemical Society, 146(7), pp. 2455-2464, (1999) (no month)
<u>n</u>	Jacobson, A.J., "Intercalation Chemistry", In: Encyclopedia of Inorganic Chemistry, Volume 3, John Wiley & Sons, pp. 1556-1602, (1994) (no month)
<u>n</u>	Yoshida, T., "Photovoltaic Properties of Screen-Printed CdTe/CdS Solar Cells on Indium-Tin-Oxide Coated Glass Substrates", J. Electrochem. Soc., 142 (9), pp. 3232-3237, (Sept. 1995)

Examiner <u>J. Lynn</u>	Date Considered <u>2/11/03</u>
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*Substitute Disclosure Statement Form (PTO-1449)

**EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Electronic Information Disclosure Statement

RECEIVED
APR 15 2003
GROUP 1

METHOD AND APPARATUS FOR INTEGRATED BATTERY DEVICES

Application: 
09/816628

Confirmation: 7107

Applicant(s): Mark Jensen

Docket
Number: 1327.008US1





Group Art
Unit: 1745

Examiner: Unknown,Unknown

search string: (US-4,299,890 or US-4,333,808 or US-4,365,107 or US-4,730,383 or US-4,740,431 or US-5,051,274 or US-5,151,848 or US-5,171,413 or US-5,180,645 or US-5,189,550 or US-5,192,947 or US-5,338,625 or US-5,411,592 or US-5,425,966 or US-5,426,561 or US-5,445,906 or US-5,448,110 or US-5,468,521 or US-5,549,989 or US-5,558,953 or US-5,571,749 or US-5,626,976 or US-5,644,207 or US-5,695,885 or US-5,763,058 or US-5,872,080 or US-5,978,207 or US-6,094,292 or US-6,222,117 or US-6,236,061).pn.

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Citation No.	Patent Number	Date	Bar Code	Patentee	Class	Subclass
<i>n</i>	P01	US-4,299,890	<i>11/1981</i> 06/18/1980		Rea, Jesse R., et al.	429	124
<i>n</i>	P02	US-4,333,808	<i>6/1982</i> 02/13/1981		Bhattacharyya, A. , et al.	204	192 D
<i>n</i>	P03	US-4,365,107	<i>12/1982</i> 02/19/1981		Yamauchi, Yutaka	136	258
<i>n</i>	P04				Balkanski,		



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GROUP 700

<i>n</i>	P04	US-4,730,383	^{3/1988} 05/05/1986		Minko	²⁹ 290	623.5	<i>n</i>
<i>n</i>	P05	US-4,740,431	^{4/1988} 12/22/1986		Little, Roger G.	429	9	
<i>n</i>	P06	US-5,051,274	^{9/1991} 09/11/1989		Goldner, Ronald B., et al.	427	38	
<i>n</i>	P07	US-5,151,848	^{9/1992} 08/24/1990		Finello, D.	361	502	
<i>n</i>	P08	US-5,171,413	^{12/1992} 09/16/1991		Arntz, Floyd O., et al.	204	192.15	
<i>n</i>	P09	US-5,180,645	^{1/1993} 03/01/1991		More, Georgina	429	127	
<i>n</i>	P010	US-5,189,550	^{2/1993} 12/13/1991		Goldner, Ronald B., et al.	359	273	
<i>n</i>	P011	US-5,192,947	^{3/1993} 02/02/1990		Neustein, Simon	340	825.44	
<i>n</i>	P012	US-5,338,625	^{8/1994} 07/29/1992		Bates, John B., et al.	429	193	
<i>n</i>	P013	US-5,411,592	^{5/1995} 06/06/1994		Ovshinsky, Stanford R., et al.	118	718	
<i>n</i>	P014	US-5,425,966	^{6/1995} 10/27/1994		Winter, Charles , et al.	427	255.1	
<i>n</i>	P015	US-5,426,561	^{6/1995} 03/31/1994		Yen, S. , et al.	361	502	
<i>n</i>	P016	US-5,445,906	^{8/1995} 08/03/1994		Hobson, D O., et al.	429	162	
<i>n</i>	P017	US-5,448,110	^{9/1995} 09/14/1993		Tuttle, John R., et al.	257	723	
<i>n</i>	P018	US-5,468,521	^{11/1995} 11/02/1994		Kanai, M. , et al.	427	575	
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<i>n</i>	P020	US-5,558,953	^{9/1996} 10/07/1994		Matsui, T. , et al.	429	194	
<i>n</i>	P021	US-5,571,749	^{11/1996} 12/28/1994		Matsuda, K. , et al.	437	113	
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n	P024	US-5,695,885	12/1997 12/06/1995 ^		Malhi, Malhi, Satwinder	429	7
n	P025	US-5,763,058	6/1998 10/07/1995 ^		Isen, Irvin, et al.	428	209
n	P026	US-5,872,080	2/1999 04/19/1995 ^		Arendt, P. N., et al.	505	238
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Signature

Examiner Name	Date
	5/19/03



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ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18
Stylesheet Version v18.0

Title of Invention	METHOD AND APPARATUS FOR INTEGRATED BATTERY DEVICES
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Application Number: 09/816628
Confirmation Number: 7107
First Named Applicant: Mark Jenson
Attorney Docket Number: 1327.008US1
Art Unit: 1745
Examiner: Unknown Unknown
Search string: (4353160 or 4440108 or 4520039 or 4633129
or 4684848 or 4862032 or 5017550 or 5022930
or 5064520 or 5089104 or 5098737 or 5115378
or 5261968 or 5273837 or 5296122 or 5314765
or 5348703 or 5393572 or 5455126 or 5482611
or 5501175 or 5501924 or 5512147 or 5528222
or 5529671 or 5536333 or 5561004 or 5567210
or 5569520 or 5569564 or 5585999 or 5593551
or 5597660 or 5599644 or 5601652 or 5612152
or 5654084 or 5705293 or 5830331 or 5863337
or 5868914 or 5935727 or 5981107 or 5995006
or 6002208 or 6033471 or 6037717 or 6042687
or 6059847 or 6103412 or 6110620 or 6130507
or 6133159 or 6136165 or 6139964 or 6147354
or 6153067 or 6181545 or 6264709).pn.

05/19/2003 H180000048 09816628
01 FC:1806 180.00 CH

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Note: Applicant is not required to submit a paper copy of cited US Patent Documents

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	2	4440108	1982-09-24	Little, Roger G., et al.		118	719
	3	4520039	1982-09-23	Ovshinsky, Stanford R.		427	35
	4	4633129	1985-04-30	Cuomo, Jerome J., et al.		313	153
	5	4684848	1985-10-15	Kaufman, Harold R., et al.		315	111.81
	6	4862032	1986-10-20	Kaufman, Harold R., et al.		313	359.1
	7	5017550	1988-03-30	Shioya, Jun , et al.		505	1

8	5022930	1989-06-20	Ackerman, Bruce , et al.	136	251
9	5064520	1990-02-14	Miyake, Kiyoshi , et al.	204	192.11
10	5089104	1990-12-03	Kanda, Naoya , et al.	204	192.11
11	5098737	1990-05-09	Collins, Carl B., et al.	427	53.1
12	5115378	1991-02-11	Tsuchiya, Yoshinobu , et al.	361	502
13	5261968	1992-01-13	Jordan, John F.	136	244
14	5273837	1992-12-23	Aitken, Bruce G., et al.	249	30
15	5296122	1992-02-18	Katsube, Teruaki , et al.	204	298.04
16	5314765	1993-10-14	Bates, John B.	429	194
17	5348703	1991-10-11	Bishop, A;an W., et al.	420	590
18	5393572	1994-07-11	Dearnaley, Geoffrey	427	523
19	5455126	1994-05-25	Bates, John B., et al.	429	127
20	5482611	1993-10-08	Helmer, , et al.	204	298.17
21	5501175	1994-07-01	Tanaka, So , et al.	117	108
22	5501924	1995-06-07	Swierbut, Wendi M., et al.	429	224
23	5512147	1994-05-25	Bates, John B., et al.	204	192.15
24	5528222	1994-09-09	Moskowitz, Paul A., et al.	340	572
25	5529671	1994-07-27	Debley, William P., et al.	204	192.34
26	5536333	1995-08-15	Foote, James B., et al.	136	260
27	5561004	1994-02-25	Bates, John B., et al.	429	162
28	5567210	1994-07-12	Bates, John B., et al.	29	623.5
29	5569520	1995-06-07	Bates, John B.	429	162
30	5569564	1995-06-07	Swierbut, Wendi M., et al.	424	224
31	5585999	1994-09-30	De Long, Hugh C., et al.	361	505
32	5593551	1995-02-28	Lai, Kwok F.	204	192.12
33	5597660	1994-05-25	Bates, John B., et al.	429	191
34	5599644	1995-06-07	Swierbut, Wendi M., et al.	429	224
35	5601652	1989-08-03	Mullin, Richard S., et al.	118	723 EB
36	5612152	1996-04-17	Bates, John B., et al.	429	152
37	5654084	1994-07-22	Egert, Charles M.	428	215
38	5705293	1997-01-09	Hobson, David O.	429	162
39	5830331	1994-09-23	Kim, Taesun E., et al.	204	192.15
40	5863337	1995-06-05	Neuman, George A., et al.	118	718
41	5868914	1996-04-12	Landsbergen, Jeroen F., et al.	204	298.06
42	5935727	1997-04-10	Chiao, Yi-HUng	429	32
43	5981107	1997-12-15	Hamano, Kouji , et al.	429	231.95
44	5995006	1996-01-15	Walsh, Brian J.	340	572.7

45	6002208	1998-07-02	Maishev, Yuri , et al.	315	111.9
46	6033471	1997-01-21	Nakanishi, Hidefumi , et al.	117	108
47	6037717	1999-01-04	Maishev, Yuri , et al.	315	111.91
48	6042687	1997-06-30	Singh, Vikram , et al.	156	345
49	6059847	1996-07-26	Farahmandi, C. J., et al.	29	25.03
50	6103412	1998-05-12	Hirano, Shinichi , et al.	429	24
51	6110620	1997-09-30	Singh, Deepika , et al.	429	223
52	6130507	1998-09-28	Maishev, Yuri , et al.	315	111.81
53	6133159	1998-08-27	Vaartstra, B. A., et al.	438	758
54	6136165	1997-11-26	Moslehi, Mehرداد M.	204	298.06
55	6139964	1995-06-06	Sathrum, Paul E., et al.	428	408
56	6147354	1998-07-02	Maishev, Yuri , et al.	250	423 R
57	6153067	1998-12-30	Maishev, Yuri , et al.	204	298.04
58	6181545	1998-09-24	Amatucci, Glenn G., et al.	361	502
59	6264709	2001-07-24	Yoon, Young S., et al.	29	623.5

Signature

Examiner Name	Date
<i>J. Lynn</i>	6/30/03



#8

ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

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Title of
Invention

METHOD AND APPARATUS FOR INTEGRATED
BATTERY DEVICES

Application Number: 09/816628
Confirmation Number: 7107
First Named Applicant: Mark Jenson
Attorney Docket Number: 1327.008US1
Art Unit: 1745
Examiner: Jonathan Crepeau
Search string: (4353160 or 4440108 or 4520039 or 4633129
or 4654726 or 4684848 or 4862032 or 5017550
or 5022930 or 5064520 or 5089104 or 5098737
or 5115378 or 5261968 or 5273837 or 5296122
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or 5455126 or 5482611 or 5501175 or 5501924
or 5512147 or 5528222 or 5529671 or 5536333
or 5561004 or 5567210 or 5569520 or 5569564
or 5585999 or 5593551 or 5597660 or 5599644
or 5601652 or 5612152 or 5654084 or 5705293
or 5830331 or 5863337 or 5868914 or 5935727
or 5981107 or 5995006 or 6002208 or 6033471
or 6037717 or 6042687 or 6059847 or 6103412
or 6110620 or 6130507 or 6133159 or 6136165
or 6139964 or 6147354 or 6153067 or 6181545
or 6264709 or 6277523).pn.

05/11/2003 18DELRI 00000063 09816628
01 FC:1806 180.00 CH

US Patent Documents

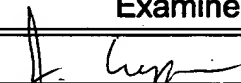
Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
W	1	4353160	1982-10-12	Armini, Anthony J., et al.		29	572
W	2	4440108	1984-04-03	Little, Roger G., et al.		118	719
W	3	4520039	1985-05-28	Ovshinsky, Stanford R.		427	35
W	4	4633129	1986-12-30	Cuomo, Jerome J., et al.		313	153
W	5	4654726	1987-02-24	Hiratani, Masahiko , et al.		429	191
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N	7	4862032	1989-08-29	Kaufman, Harold R., et al.	313	359.1
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N	52	6103412	2000-08-15	Hirano, Shinichi , et al.	429	24
N	53	6110620	2000-08-29	Singh, Deepika , et al.	429	223
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N	55	6133159	2000-10-17	Vaartstra, B. A., et al.	438	758
N	56	6136165	2000-10-24	Moslehi, Mehrdad M.	204	298.06
N	57	6139964	2000-10-31	Sathrum, Paul E., et al.	428	408
N	58	6147354	2000-11-14	Maishev, Yuri , et al.	250	423 R
N	59	6153067	2000-11-28	Maishev, Yuri , et al.	204	298.04
N	60	6181545	2001-01-30	Amatucci, Glenn G., et al.	361	502
N	61	6264709	2001-07-24	Yoon, Young S., et al.	29	623.5
N	62	6277523	2001-08-21	Giron, Jean-Christophe	429	304

Signature

Examiner Name	Date
	6/30/03

#9

PTO/SB/08A(10-01)

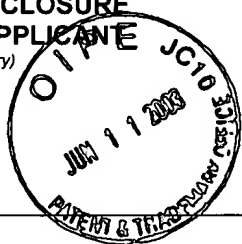
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Substitute for form 1449A/PTO

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use as many sheets as necessary)



Complete if Known

Application Number	09/816628
Filing Date	March 23, 2001
First Named Inventor	Mark L. Jenson
Group Art Unit	1746
Examiner Name	Jonathan Crepeau

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TC 1700

Sheet 1 of 4

Attorney Docket No: 1327.008US1

US PATENT DOCUMENTS

Examiner Initial *	USP Document Number	Publication Date	Name of Patentee or Applicant of cited Document	Class	Subclass	Filing Date If Appropriate
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N	JP-06067018/	03/11/1994	Yokoe, Katsuhiko	G02B	5/28	
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N	JP-07-050229 ✓	02/21/1995	Katsumi, Y.	H01G	9/028	
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N	JP-07057739 ✓	03/03/1995	Ezaka, Yukio	H01M	4/88	
N	JP-08017179 ✓	01/19/1996	Kagawa, Hiroshi	G11B	33/12	
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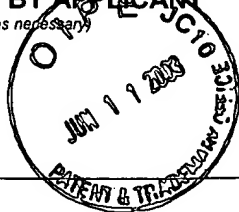
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Application Number	09/816628
Filing Date	March 23, 2001
First Named Inventor	Mark L. Jenson
Group Art Unit	1746
Examiner Name	Jonathan Crepeau

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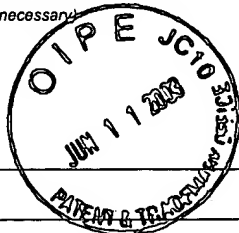
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